

<b>Notice of References Cited</b>	Application/Control No. 10/544,277		Applicant(s)/Patent Under Reexamination TWISS, ADAM	
	Examiner KEVIN S. MAI		Art Unit 2152	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0062375	05-2002	Teodosiu et al.	709/226
*	B	US-2004/0148434	07-2004	Matsubara et al.	709/246
*	C	US-2002/0049760	04-2002	Scott et al.	707/10
*	D	US-2002/0194108	12-2002	Kitze, Christopher Allin	705/37
*	E	US-2004/0088646	05-2004	Yeager et al.	715/500
*	F	US-2006/0168304	07-2006	Bauer et al.	709/232
*	G	US-2007/0097885	05-2007	Traversat et al.	370/254
*	H	US-2009/0182842	07-2009	Dutta et al.	709/218
*	I	US-2009/0106355	04-2009	Harrow et al.	709/203
*	J	US-2007/0192474	08-2007	Decasper et al.	709/223
*	K	US-2005/0149481	07-2005	Hesselink et al.	707/001
*	L	US-7,062,555	06-2006	Kouznetsov et al.	709/225
*	M	US-2002/0010866	01-2002	McCullough et al.	713/201

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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